

| | | | | | | | | | |
|--|----------|---|--------------|--------------------------------|---|---|--|---|--|
| INFORMATION DISCLOSURE CITATION IN AN APPLICATION | | | | | | ATTY. DOCKET NO. 65933-067 | | SERIAL NO. Divisional of Appl. No. 10/378,907 | |
| (PTO-1449) | | | | | | APPLICANT Isao HASEGAWA, et al. | | | |
| | | | | | | FILING DATE March 10, 2004 | | GROUP 2879 | |
| U.S. PATENT DOCUMENTS | | | | | | | | | |
| EXAMINER'S INITIALS | CITE NO. | Document Number Number-Kind Code ₂ (if known) | | Publication Date MM-DD-YYYY | Name of Patentee or Applicant of Cited Document | Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear | | | |
| S.R. | | US | 6,281,552 B1 | 08/28/2001 | Kawasaki et al. | | | | |
| S.R. | | US | 6,093,934 | 07/25/2000 | Yamazaki et al. | | | | |
| S.R. | | US | 6,124,604 | 09/26/2000 | Koyama et al. | | | | |
| | | US | | | | | | | |
| | | US | | | | | | | |
| | | US | | | | | | | |
| | | US | | | | | | | |
| | | US | | | | | | | |
| | | US | | | | | | | |
| | | US | | | | | | | |
| | | US | | | | | | | |
| FOREIGN PATENT DOCUMENTS | | | | | | | | | |
| EXAMINER'S INITIALS | CITE NO. | Foreign Patent Document Country Codes - Number - Kind Codes (if known) | | Publication Date MM-DD-YYYY | Name of Patentee or Applicant of Cited Document | Pages, Columns, Lines Where Relevant Figures Appear | | Translation Yes No | |
| S.R. | | JP 11-219146 | | 08/10/1999 | | | | | |
| S.R. | | JP 2001-60076 | | 03/06/2001 | | | | | |
| S.R. | | JP 2001-282136 | | 10/12/2001 | | | | | |
| S.R. | | JP 2000-221903 | | 08/11/2000 | | | | | |
| S.R. | | JP 11-260562 | | 09/24/1999 | | | | | |
| S.R. | | JP 08-129358 | | 05/21/1996 | | | | | |
| S.R. | | JP 08-54836 | | 02/27/1996 | | | | | |
| S.R. | | JP 5-249916 | | 09/28/1993 | | | | | |
| S.R. | | JP 10-319872 | | 12/04/1998 | | | | | |
| S.R. | | WO 98/36407 | | 08/20/1998 | | | | | |
| S.R. | | JP 63-250873 | | 10/18/1988 | | | | | |
| S.R. | | JP 61-138259 | | 08/27/1986 | | | | | |
| OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) | | | | | | | | | |
| EXAMINER'S INITIALS | CITE NO. | Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate)at, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. | | | | | | | |
| S.R. | | *Al-Mo (Aluminium-Molybdenum)* L.Brewer et al., Binary Alloy Phase Diagrams vol. 1, ed. Thaddeus B. Massalski, (Dec.1980) pp. 133-134. | | | | | | | |
| EXAMINER Sikha Roy | | | | | DATE CONSIDERED 11/3/04 | | | | |

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
65933-067SERIAL NO.
10796,189APPLICANT
Isao HASEGAWA, et al.FILING DATE
March 10, 2004GROUP
2821 2879

U.S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | CITE NO. | Document Number Number-Kind Code ² (if known) | Publication Date MM-DD-YYYY | Name of Patentee or Applicant of Cited Document | Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear |
|---------------------|----------|---|--------------------------------|---|---|
| S.R. | B2 | US 6,583,581 | 06/24/2003 | Kaneko et al. | |
| S.R. | B1 | US 6,489,046 | 12/03/2002 | Ikeda et al. | |
| | | US 6,093,934 | 07/25/2000 | Yamazaki et al. | |
| | | US 6,124,604 | 09/26/2000 | Koyama et al. | |
| | B1 | US 6,281,552 | 08/28/2001 | Kawasaki et al. | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |

FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | CITE NO. | Foreign Patent Document Country Codes - Number - Kind Codes (if known) | Publication Date MM-DD-YYYY | Name of Patentee or Applicant of Cited Document | Pages, Columns, Lines Where Relevant Figures Appear | Translation | |
|---------------------|----------|--|--------------------------------|---|---|-------------|----|
| | | | | | | Yes | No |
| S.R. | | JP 02-039536 with English abstract | 02/08/1990 | Hitachi Ltd. | | | |
| S.R. | | JP 2001-308094 w/English abstract | 11/02/2001 | OKI Electric Ind Co. Ltd. | | | |
| S.R. | | JP 10-199827 with English abstract | 07/31/1998 | Casio Comput Co. Ltd. | | | |
| S.R. | | JP 2000-349298 w/English abstract | 12/15/2000 | Semiconductor Energy Lab Co. Ltd. | | | |

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

| EXAMINER'S INITIALS | CITE NO. | Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. |
|---------------------|----------|---|
| | | |
| | | |
| | | |

EXAMINER

Sikhar Roy

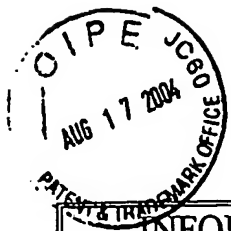
DATE CONSIDERED

11/3/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

* Cited in IDS filed 3/10/04



SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
65933-067SERIAL NO.
10/796,189APPLICANT
Isao HASEGAWA, et al.FILING DATE
March 10, 2004GROUP
~~2824~~ 2879

U.S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | CITE NO. | Document Number Number-Kind Code ² (if known) | Publication Date MM-DD-YYYY | Name of Patentee or Applicant of Cited Document | Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear |
|------------------------|-------------|---|--------------------------------|--|---|
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |
| | | US | | | |

FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | CITE NO. | Foreign Patent Document Country Codes -Number -Kind Codes (if known) | Publication Date MM-DD-YYYY | Name of Patentee or Applicant of Cited Document | Pages, Columns, Lines Where Relevant Figures Appear | Translation | |
|------------------------|-------------|--|--------------------------------|--|--|-------------------------------|----|
| | | | | | | Yes | No |
| S.R. | | JP 2000-277607 | 10/06/2000 | TOSHIBA CORP. | | JAPAN (w/English Abstract) | |
| S.R. | | JP 10-170955 | 06/26/1998 | FUJITSU LTD | | JAPAN (w/English Abstract) | |
| S.R. | | JP 11-111990 | 04/23/1999 | SANYO ELECTRIC CO LTD | | JAPAN (w/English Abstract) | |
| S.R. | | JP 2000-236097 | 08/29/2000 | SEMICONDUCTOR ENERGY LAB CO LTD. | | JAPAN (w/English Abstract) | |
| | | | | | | | |

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

| EXAMINER'S INITIALS | CITE NO. | Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. |
|------------------------|-------------|---|
| | | |
| | | |
| | | |
| | | |

EXAMINER

Sikha Roy

DATE CONSIDERED

11/3/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

* Cited in IDS filed 8/17/04